

Search Notes

Application/Control No.

10/755,716

Examiner

Nam Huynh

Applicant(s)/Patent under
Reexamination

HAKOBYAN ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	410 411	11/23/2007	NTH
	61		
	435.1		
	450		
	455		
	456.5		
	456.6		
370	313	11/23/2007	NTH
	326		
	330		
	335 336		
	342-346		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See EAST search notes.	11/23/2007	NTH